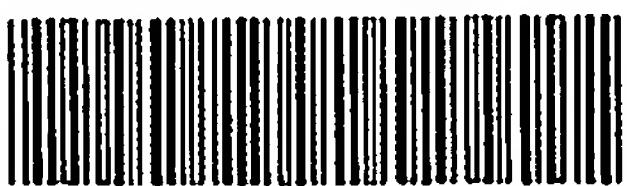


Search Notes**Application/Control No.**

10/710,414

Examiner

Alan S. Chen

Applicant(s)/Patent under Reexamination

BILAK ET AL.

Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	22	5/26/2006	ASC
	52		
	53		
	54		
	55		
	56		
↓	57	↓	↓
<i>Limited class search</i>			
		11/22/06	ASC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT	5/26/2006	ASC
<i>updated EAST</i>	<i>11/22/06</i>	<i>ASC</i>
<i>updated EAST</i>	<i>3/16/07</i>	<i>ASC</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
		?	?
		?	1
<i>see search history, prototypes</i>	<i>3/16/07</i>		<i>ASC</i>